

Notice of References Cited	Application/Control No. 10/502,055		Applicant(s)/Patent Under Reexamination TAIRA ET AL.	
	Examiner Tuan N. Nguyen		Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,585,648	12-1996	Tischler, Michael A.	257/77
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NON-PATENT DOCUMENTS

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*	U	W. KOECHNER, et al., 'Birefringence of YAG: Nd laser rods as a function of growth direction', JOURNAL OF THE OPTICAL SOCIETY OF AMERICA, vol. 61, no. 6, pages 758-766.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.